## Notice of References Cited

Application/Control No. 10/032,200

Applicant(s)/Patent Under Reexamination
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BINH Q. TRAN

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-US006093378A	07-2000	Deeba et al.	423/213.5
	В	US-US006167696B1	01-2001	Maaseidvaag et al.	60/274
	С	US-US006367246B1	04-2002	Hirota et al.	60/295
	۵	US-US005682740	11-1997	Kawamura	60/297
	ш	US-US006314722B1	11-2001	Matros et al.	60/274
	F	US-US005746989	05-1998	Murachi et al.	423/212
	G	US-US006051040A	04-2000	Peter-Hoblyn	44/358
	Н	US-US006038854A	03-2000	Penetrante et al.	60/297
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	w				
	х				

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